Application/Control No. Applicant(s)/Patent Under Reexamination 09/828,149 WASENIUS, REIDAR Notice of References Cited Examiner Art Unit Page 1 of 1 Raymond S. Dean 2684 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY 08-2003 US-6,604,140 Beck et al. 709/226 Α 05-2005 Lunsford et al. 709/216 US-6,901,434 В US-C US-D US-Ε US-F US-G Н US-US-US-US-US-L М US-FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) Haartsen, J.C.; Mattisson, S.; Proceedings of the IEEE, Volume: 88, Issuie: 10, Oct. 200 Pages 1651 - 1661

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.